## Notice of References Cited

Reexan		nt(s)/Patent Under nination RSON, KEVIN GARY	
Examiner	Art Unit		
Syed J Ali	2127	Page 1 of 1	

## U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-6,539,501	03-2003	Edwards, Jermaine Charles	714/45
	В	US-6,637,024	10-2003	Johnson et al.	717/124
	C	US-6,826,746	11-2004	Evans et al.	717/124
	D	US-6,829,771	12-2004	Bahrs et al.	719/318
	E	US-			
	F	US-			
	G	US-			
	Н	US-			
	1	US-			
	J	US-			
	к	US-			
	L	US-		_	
	М	US-			

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	Q	,				
	R					
	S		_			
	Т					

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	ט	Putrycz, Erik. "Using Trace Analysis for Improving Performance in COTS Systems". National Research Council of Canada, 2004, pgs. 1-13.
	V	
	w	
	x	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

Dates in MM-YYYYY format are publication dates. Classifications may be US or foreign.